

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/586,974	ICHIKAWA ET AL.	
Examiner	Art Unit	

2876

Daniel I. Walsh

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Search attached	10/27/2007	DW	
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